HOPERF ELECTRONIC

| Approved by: |
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| Checked by: |
| Issued by: |

SPECIFICATION

PRODUCT: SAW RESONATOR

MODEL: HR868.35   F-11

HOPE MICROELECTRONICS CO.,LIMITED

The HR868.35 is a true one-port, surface-acoustic-wave (**SAW**) resonator in a low-profile metal **F-11** case. It provides reliable, fundamental-mode, quartz frequency stabilization i.e. in transmitters or local oscillators operating at **868.350** MHz.

1.Package Dimension (F-11)
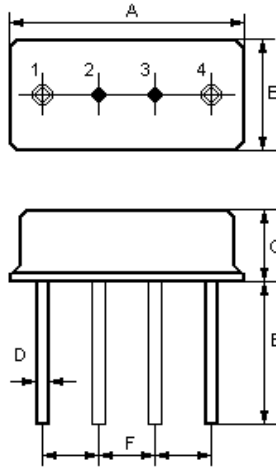
Pin	Configuration
1,4	Input / Output
2/3	Case Ground

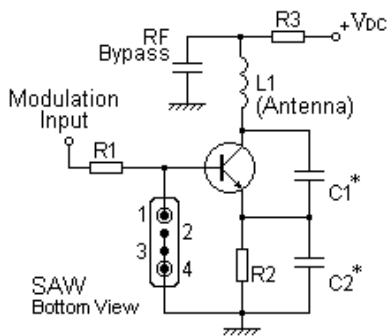| Dimension	Data (unit: mm)
A	11.0±0.3
B	4.5±0.3
C	3.2±0.3
D	0.45±0.1
E	5.0±0.5
F	2.54±0.2

2.Marking

HR868.35

Color: Black or Blue

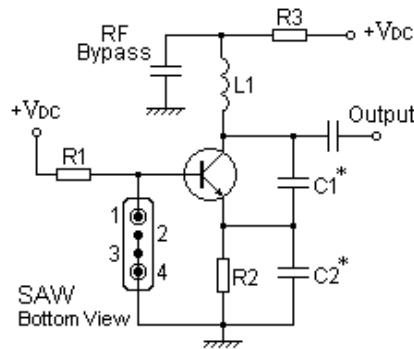## 3.Equivalent LC Model and Test Circuit
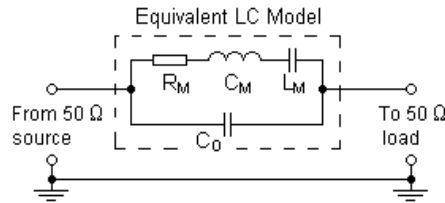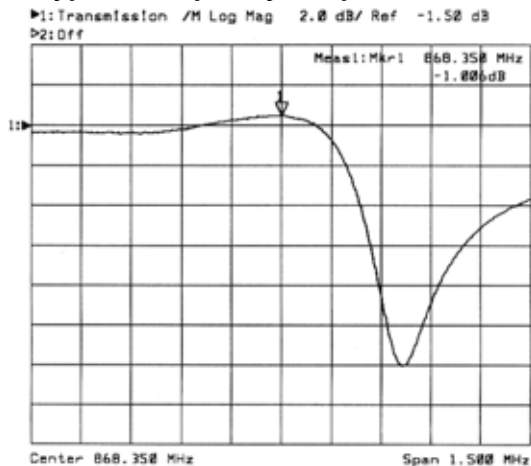

4.Typical Application Circuits
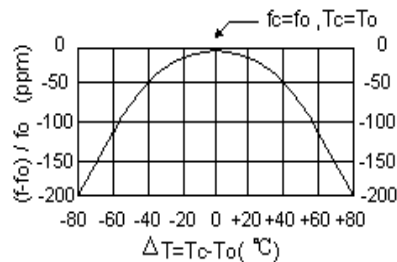
1) Low-Power Transmitter Application

2) Local Oscillator Application

5.Typical Frequency Response

6.Temperature Characteristics

The curve shown above accounts for resonator contribution only and does not include oscillator temperature characteristics.

7.Performance

7-1.Maximum Ratings

Rating		Value	Unit
CW RF Power Dissipation	P	0	dBm
DC Voltage Between Any two Pins	V_{DC}	± 30	V
Storage Temperature Range	T_{stg}	-40 to +85	
Operating Temperature Range	T_A	-10 to +60	

7-2.Electronic Characteristics

Characteristic		Sym	Minimum	Typical	Maximum	Unit
Center Frequency (+25)	Absolute Frequency	f_C	868.200		868.500	MHz
	Tolerance from 868.350MHz	Δf_C		± 150		kHz
Insertion Loss		IL		1.3	1.8	dB
Quality Factor	Unloaded Q	Q_U		11,600		
	50 Ω Loaded Q	Q_L		1,600		
Temperature Stability	Turnover Temperature	T_0	25		55	
	Turnover Frequency	f_0		f_C		kHz
	Frequency Temperature Coefficient	FTC		0.032		ppm/ ²
Frequency Aging Absolute Value during the First Year		$\lvert f_A \rvert$		10		ppm/yr
DC Insulation Resistance Between Any Two Pins			1.0			MΩ
RF Equivalent RLC Model	Motional Resistance	R_M		16	23	Ω
	Motional Inductance	L_M		34.0348		μH
	Motional Capacitance	C_M		0.9880		fF
	Pin 1 to Pin 4 Static Capacitance	C_0	1.80	2.10	2.40	pF

ⓘ**CAUTION: Electrostatic Sensitive Device. Observe precautions for handling!**

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1. The center frequency, f_C, is measured at the minimum IL point with the resonator in the 50   test system.
2. Unless noted otherwise, case temperature T_C = +25°C±2°C.
3. Frequency aging is the change in f_C with time and is specified at +65°C or less. Aging may exceed the specification for prolonged temperatures above +65°C. Typically, aging is greatest the first year after manufacture, decreasing in subsequent years.
4. Turnover temperature, T_0, is the temperature of maximum (or turnover) frequency, f_0. The nominal frequency at any case temperature, T_C, may be calculated from: $f = f_0 [1 - FTC (T_0 - T_C)^2]$.
5. This equivalent RLC model approximates resonator performance near the resonant frequency and is provided for reference only. The capacitance C_0 is the measured static (nonmotional) capacitance between Pin1 and Pin4. The measurement includes case parasitic capacitance.
6. Derived mathematically from one or more of the following directly measured parameters: f_C, IL, 3 dB bandwidth, f_C versus T_C, and C_0.
7. The specifications of this device are based on the test circuit shown above and subject to change or obsolescence without notice.
8. Typically, equipment utilizing this device requires emissions testing and government approval, which is the responsibility of the equipment manufacturer.
9. Our liability is only assumed for the Surface Acoustic Wave (SAW) component(s) per se, not for applications, processes and circuits implemented within components or assemblies.
10. For questions on technology, prices and delivery, please contact our sales offices or e-mail sales@hoperf.com.